

Notice of References Cited	Application/Control No. 10/506,645	Applicant(s)/Patent Under Reexamination ABEKAWA ET AL.	
	Examiner Christina Johnson	Art Unit 1725	Page 1 of 1

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	A	US-2003/0049305	03-2003	Von Rymon Lipinski et al.	424/439
	B	US-6,734,133	05-2004	Weisbeck et al.	502/119
	C	US-6,759,540	07-2004	Oguchi et al.	549/529
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	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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